

SEMITRANS[®] 3

Superfast IGBT Modules

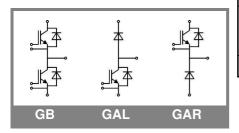
SKM 300GB063D SKM 300GAR063D SKM 300GAL063D

Features

- NPT- Non punch-through IGBT
- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of V_{CEsat}
- 50 % less turn off losses
- 30 % less short circuit current
- Very low C_{ies}, C_{oes}, C_{res}
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
- Large clearance (13 mm) and creepage distances (20 mm)

Typical Applications*

- Switching (not for linear use)
- Switched mode power supplies
- · AC inverter servo drives
- UPS uninterruptable power supplies
- · Welding inverters



Absolute Maximum Ratings $T_c = 25 ^{\circ}\text{C}$, unless otherwise specified					
Symbol	Conditions		Values	Units	
IGBT					
V_{CES}	T _j = 25 °C		600	V	
I _C	T _j = 150 °C	T _{case} = 25 °C	400	А	
		T _{case} = 70 °C	300	Α	
I _{CRM}	I _{CRM} =2xI _{Cnom}		600	Α	
V_{GES}			± 20	V	
t _{psc}	V_{CC} = 300 V; $V_{GE} \le 20$ V; $V_{CES} < 600$ V	T _j = 125 °C	10	μs	
Inverse [Diode			•	
I_{F}	T _j = 150 °C	T_{case} = 25 °C	250	Α	
		T _{case} = 80 °C	170	А	
I_{FRM}	I _{FRM} =2xI _{Fnom}		600	Α	
I _{FSM}	$t_p = 10 \text{ ms}; \text{ sin.}$	T _j = 150 °C	1600	А	
Freewhe	eling Diode				
I _F	T _j = 150 °C	$T_c = 25 ^{\circ}C$	400	Α	
		T _c = 80 °C	270	Α	
I _{FRM}	I _{FRM} =2xI _{Fnom}		800	Α	
I _{FSM}	$t_p = 10 \text{ ms}; \text{ sin.}$	T _j = 150 °C	2800	А	
Module					
$I_{t(RMS)}$			500	Α	
T_{vj}			- 40 + 150	°C	
T _{stg}			- 40 + 125	°C	
V _{isol}	AC, 1 min.		2500	V	

Characteristics $T_c =$			25 °C, unless otherwise specified			
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_{C} = 6 \text{ mA}$		4,5	5,5	6,5	V
I _{CES}	$V_{GE} = 0 V, V_{CE} = V_{CES}$			0,2	0,6	mA
V_{CE0}		T _j = 25 °C		1,05		V
		T _j = 125 °C		1		V
r _{CE}	V _{GE} = 15 V	T _j = 25°C		3,2		mΩ
		T _j = 125°C		4,7		mΩ
V _{CE(sat)}	I _{Cnom} = 300 A, V _{GE} = 15 V	T _j = 25°C _{chiplev.}		2,1	2,5	V
		$T_j = 125^{\circ}C_{chiplev.}$		2,4	2,8	V
C _{ies}				17		nF
C _{oes}	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		2		nF
C _{res}				1,2		nF
Q_G	V _{GE} = 0V+15V			720		nC
R _{Gint}	$T_j = {^{\circ}C}$			1,2		Ω
t _{d(on)}				160		ns
t _r	$R_{Gon} = 6 \Omega$	V _{CC} = 300V		80		ns
E _{on}		I _C = 300A		14		mJ
t _{d(off)}	$R_{Goff} = 6 \Omega$	T _j = 125 °C		550		ns
t _f		$V_{GE} = \pm 15V$		50		ns
E _{off}				13		mJ
R _{th(j-c)}	per IGBT				0,09	K/W



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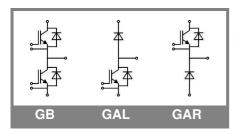
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Characteristics							
Symbol	Conditions		min.	typ.	max.	Units	
Inverse Diode							
$V_F = V_{EC}$	I_{Fnom} = 300 A; V_{GE} = 0 V	$T_j = 25 ^{\circ}C_{\text{chiplev.}}$		1,65	2	V	
		$T_j = 125 ^{\circ}C_{\text{chiplev.}}$		1,65	2	V	
V_{F0}		T _j = 125 °C			0,9	V	
r _F		T _j = 125 °C		3	3,7	mΩ	
I _{RRM}	I _F = 300 A	T _j = 125 °C		120		Α	
Q_{rr}				18		μC	
E _{rr}	$V_{GE} = -15 \text{ V}; V_{CC} = 300 \text{ V}$					mJ	
$R_{th(j-c)D}$	per diode				0,25	K/W	
	eling Diode						
$V_F = V_{EC}$	I_{Fnom} = 400 A; V_{GE} = 0 V	$T_j = 25 ^{\circ}C_{chiplev.}$		1,65	2	V	
		$T_j = 125 ^{\circ}C_{chiplev.}$		1,65	2	V	
V_{F0}		T _j = 125 °C			0,9	V	
r _F		T _j = 125 °C T _j = 125 °C			3	V	
I _{RRM}	I _F = 300 A	T _j = 125 °C		130		Α	
Q_{rr}				23		μC	
E _{rr}	$V_{GE} = -15 \text{ V}; V_{CC} = 300 \text{ V}$					mJ	
$R_{th(j-c)FD}$	per diode				0,15	K/W	
Module							
L _{CE}				15	20	nΗ	
R _{CC'+EE'}	res., terminal-chip	T _{case} = 25 °C		0,35		mΩ	
		T _{case} = 125 °C		0,5		mΩ	
R _{th(c-s)}	per module				0,038	K/W	
M _s	to heat sink M6		3		5	Nm	
M _t	to terminals M6		2,5		5	Nm	
w					325	g	

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

*IMPORTANT INFORMATION AND WARNINGS

The specifications of SEMIKRON products may not be considered as guarantee or assurance of product characteristics

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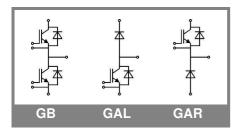
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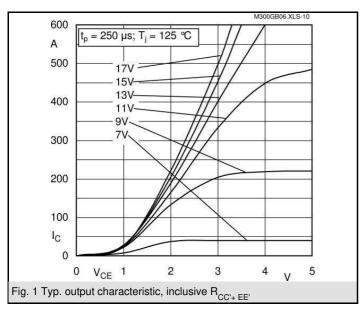
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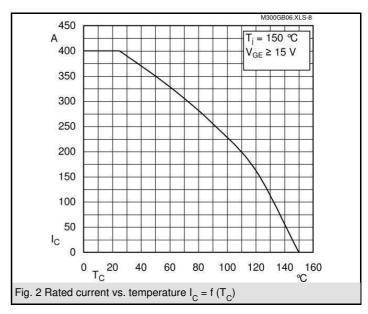
Typical Applications*

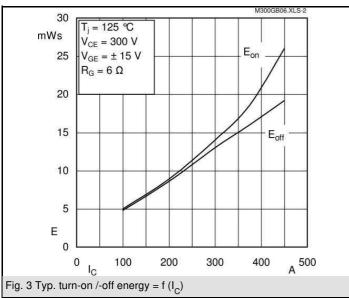
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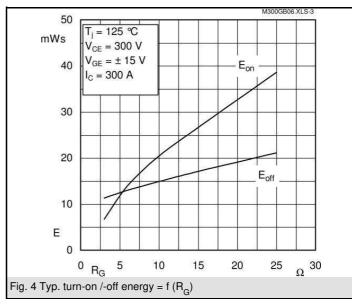


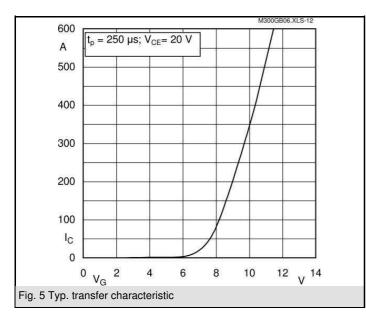
Z _{th}			
Symbol	Conditions	Values	Units
${f Z}_{{\sf R_i}}$			
R _i	i = 1	65	mk/W
R_i	i = 2	19	mk/W
R_i	i = 3	4,7	mk/W
R_i	i = 4	1,3	mk/W
tau _i	i = 1	0,0518	s
tau _i	i = 2	0,0241	s
tau _i	i = 3	0,0021	s
tau _i	i = 4	0,0001	s
Z _{th(j-c)D}	<u> </u>		<u>.</u>
R _i	i = 1	140	mk/W
R_i	i = 2	85	mk/W
R_i	i = 3	20,55	mk/W
R_i	i = 4	4,45	mk/W
tau _i	i = 1	0,0613	s
tau _i	i = 2	0,0041	s
tau _i	i = 3	0,0045	s
tau _i	i = 4	0,0003	s

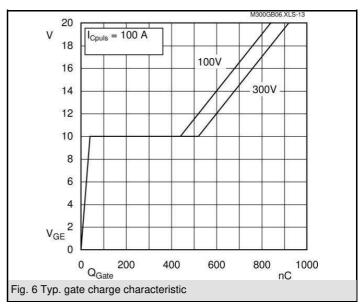


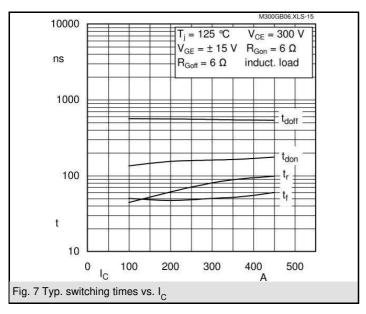


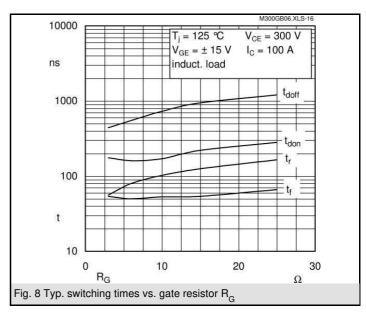


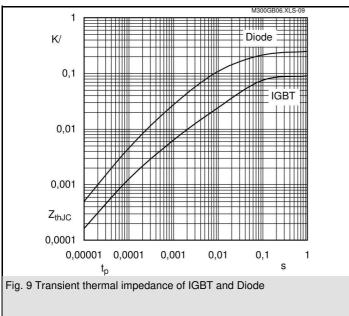


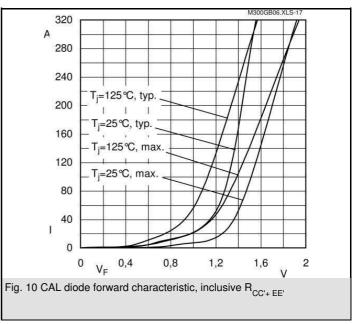


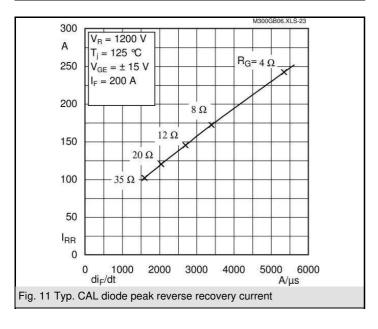


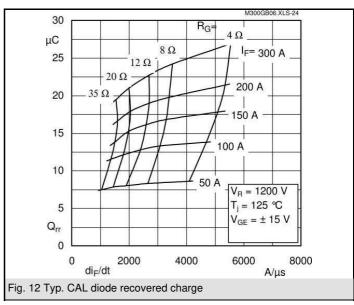






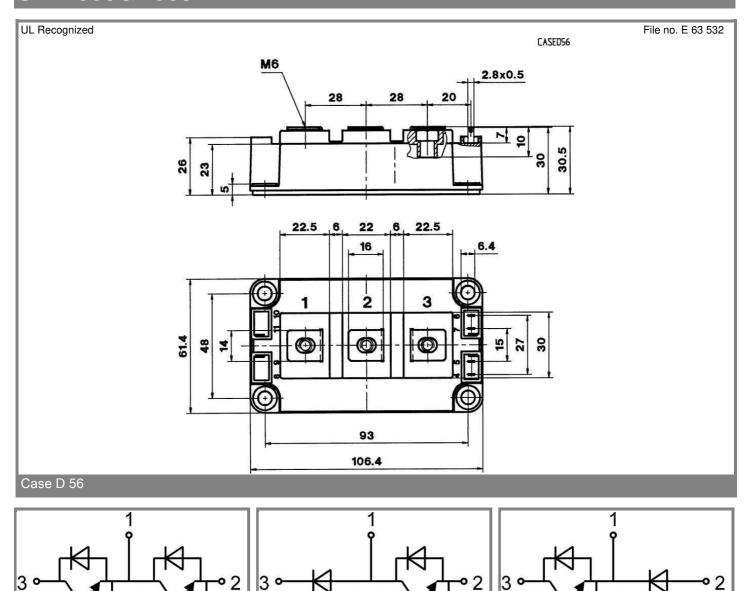






Case D 56

GAL



Case D 57 (→ D 56)

GAR

Case D 58 (→ D 56)